

GTS Global United Technology Services Co., Ltd.

Report No.: GTSE15030028101

TEST REPORT			
Applicant:	Bentel Sistem SRL		
Address of Applicant:	HEGEL STREET NO.1,400448 Cluj-Napoca, Romania		
Equipment Under Test (B	EUT)		
Product Name:	Bullet camera		
Model No.:	NGC-7321, NGC-7326, NGC-7331, NGC-7332, NAC-T331, NAC-T351		
Trade Mark:	navaio		
Applicable standards:	EN 55022:2010/AC:2011		
	EN 55022:2010/AC:2011 EN 55024:2010 EN 61000-3-2:2006+A1:2009+A2:2009 EN 61000-3-3:2013		
Date of sample receipt:	EN 55024:2010 EN 61000-3-2:2006+A1:2009+A2:2009		
Date of sample receipt: Date of Test:	EN 55024:2010 EN 61000-3-2:2006+A1:2009+A2:2009 EN 61000-3-3:2013		
	EN 55024:2010 EN 61000-3-2:2006+A1:2009+A2:2009 EN 61000-3-3:2013 07 Nov. 2012		

In the configuration tested, the EUT complied with the standards specified above.



Robinson Lo Laboratory Manager

This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product and does not permit the use of the GTS product certification mark. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

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2 Version

Report No. Version No.		Date	Description	
GTSE13050076501	00	28 May, 2013	Original	
GTSE13090151101	01	10 Sep. 2013	New report 1*	
GTSE14060092701	02	05 Jun. 2014	New report 2*	
GTSE15030028101	20028101 03 19 Mar. 2015		New report 3*	

Remark:

The differences between New report3* and New report2* are applicant, address of applicant, model name and trade mark, there is no difference test, for the detail, please refer to section 1 and 5.

Prepared by:

Young bu

Date:

19 Mar. 2015

Project Engineer

Reviewed by:

Reviewer

Date:

19 Mar. 2015

Project No.: GTSE150300281AV

GTS

Report No.: GTSE15030028101

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4 Test Summary

Test item	Test Requirement	Test Method	Class / Severity	Result
Radiated Emission #	EN 55022	EN 55022	Class B	Pass
Conducted Emission	EN 55022	EN 55022	Class B	Pass
Harmonic Emission	EN 61000-3-2	EN 61000-3-2	N/A	N/A
Flicker Emission	EN 61000-3-3	EN 61000-3-3	Clause 5	Pass
Electrostatic discharge	EN 55024	EN 61000-4-2:2009	Contact ±2,±4 kV Air ±2,±4,±8 kV	Pass
Radio-frequency electromagnetic field Amplitude modulated	EN 55024	EN 61000-4-3: 2006+A1: 2008 +A2: 2010	3V/m 80%, 1kHz, AM	Pass
Electrical fast transients	EN 55024	EN 61000-4-4: 2012	$AC \pm 1.0 kV$	Pass
Surges	EN 55024	EN 61000-4-5: 2014	±1kV D.M	Pass
Radio-frequency continuous conducted	EN 55024	EN 61000-4-6: 2014	3Vrms (emf), 80%, 1kHz Amp. Mod.	Pass
Voltage dips and Voltage interruptions	EN 55024	EN 61000-4-11: 2004	0 % U_{T}^{*} for 0.5per 0 % U_{T}^{*} for 250per 70 % U_{T}^{*} for 25per	Pass

Remark:

1. Pass:Comply with the essential requirements in the standard.

2. U_T : the nominal supply voltage; D.M: Differential Mode.

3. N/A : not applicable

4. # Refer to EN55022 clause 6.2 conditional testing procedure :

The highest frequency generated or used in the EUT	Test frequency range of Radiated emission
<108MHz	30MHz ~ 1GHz
108MHz ~ 500MHz	30MHz ~ 2GHz
500MHz ~ 1GHz	30MHz ~ 5GHz
>1GHz	30MHz ~ 5times the highest frequency or
	30MHz ~ 6 GHz, whichever is less

The highest frequency of the internal sources of the EUT is 800MHz.



5 General Information

5.1 Client Information

Applicant:	Bentel Sistem SRL
Address of Applicant:	HEGEL STREET NO.1, 400448 Cluj-Napoca, Romania
Manufacturer:	SHENZHEN TVT DIGITAL TECHNOLOGY CO., LTD.
Address of Manufacturer:	6/E, North Block, CE Lighting House, Hi-Tech Park, Nanshan District, Shenzhen, P.R. China

5.2 General Description of EUT

Product Name:	Bullet camera	
Model No.:	NGC-7321, NGC-7326, NGC-7331, NGC-7332, NAC-T331,	
	NAC-T351	
Power supply:	DC 12.0V, 1A (power from adapter)	

5.3 Test mode and Test voltage

Test mode:	Test mode:		
On mode	Keep the EUTworking normal.		
Test voltage:	Test voltage:		
Adapter: Input AC 230V/50Hz			
Output DC12.0V/1A			

Description	Manufacturer	Model	Serial Number
PC Host	C Host Lenovo PC Host M6900		EA05257893
MONITOR	DELL VS12490		GTS237-1
TV	PHILIPS 19PFL3120/T3		AU1A1212002906
KEYBOARD	DELL	SK-8115	N/A
MOUSE	DELL MOUSE	N/A	N/A
PRINTER	Canon	IP1600	GTS222
DVD Player	Pioneer	DV-420V-K	090502-11

5.4 Description of Support Units

5.5 Deviation from Standards

None.

Abnormalities from Standard Conditions 5.6

None.

5.7 Monitoring of EUT for All Immunity Test

Visual:	Monitor the display of the EUT
Audio:	Monitor the sound from the EUT

5.8 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS — Registration No.: CNAS L5775

CNAS has accredited Global United Technology Services Co., Ltd. to ISO/IEC 17025 General Requirements for the competence of testing and calibration laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testingand Calibration Laboratories) for the competence in the field of testing.

FCC —Registration No.: 600491

Global United Technology Services Co., Ltd., Shenzhen EMC Laboratory has been registered and fuly described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in files. Registration 600491, July 20, 2010.

Industry Canada (IC) —Registration No.: 9079A-1

The 3m Semi-anechoic chamber of Global United Technology Services Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 9079A-1.

5.9 Test Location

CS and RS test items were performed at:
SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch E&E Lab,
No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China. 518057.
All other test items were performed at:
Global United Technology Services Co., Ltd. Address: 2nd Floor, Block No.2, Laodong Industrial Zone, Xixiang Road Baoan District, Shenzhen, China

Tel: 0755-27798480; Fax: 0755-27798960



6 Test Instruments List

Radi	Radiated Emission						
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)	
1	3m Semi- Anechoic Chamber	ZhongYu Electron	9.0(L)*6.0(W)* 6.0(H)	GTS250	Mar. 30 2011	Mar. 29 2013	
2	Control Room	ZhongYu Electron	6.2(L)*2.5(W)* 2.4(H)	GTS251	N/A	N/A	
3	ESU EMI Test Receiver	R&S	ESU26	GTS203	Jul. 07 2012	Jul. 06 2013	
4	BiConiLog Antenna	SCHWARZBECK	VULB9163	GTS214	Mar. 10 2012	Mar. 09 2013	
5	Double -ridged waveguide horn	SCHWARZBECK	9120D	GTS208	Mar. 10 2012	Mar. 09 2013	
6	RF Amplifier	HP	8347A	GTS204	Jul. 07 2012	Jul. 06 2013	
7	Preamplifier	HP	8349B	GTS206	Jul. 07 2012	Jul. 06 2013	
8	EMI Test Software	AUDIX	E3	N/A	N/A	N/A	
9	Coaxial cable	GTS	N/A	GTS210	Jul. 07 2012	Jul. 06 2013	
10	Coaxial Cable	GTS	N/A	GTS211	Jul. 07 2012	Jul. 06 2013	
11	Thermo meter	N/A	N/A	GTS256	Jul. 06 2012	Jul. 05 2013	

Cond	lucted Emission					
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)
1	Shielding Room	ZhongYu Electron	7.3(L)x3.1(W)x2.9(H)	GTS252	Sep. 08 2011	Sep. 07 2013
2	EMI Test Receiver	R&S	ESCS30	GTS223	Jul. 07 2012	Jul. 06 2013
3	Pulse Limiter	R&S	ESH3-Z2	GTS224	Jul. 07 2012	Jul. 06 2013
4	Coaxial Switch	ANRITSU CORP	MP59B	GTS225	Jul. 07 2012	Jul. 06 2013
5	Artificial Mains Network	SCHWARZBECK MESS	NSLK8127	GTS226	Jul. 07 2012	Jul. 06 2013
6	Coaxial Cable	GTS	N/A	GTS227	Jul. 07 2012	Jul. 06 2013
7	EMI Test Software	AUDIX	E3	N/A	N/A	N/A
8	Thermo meter	KTJ	TA328	GTS233	Jul. 27 2012	Jul. 26 2013

Elect	Electrical fast transients/ Surges/ Voltage dips and interruptions							
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)		
1	EMTEST system	EMTEST	UCS500N	GTS239	Jul. 07 2012	Jul. 06 2013		
2	Thermo meter	KTJ	TA328	GTS238	Jul. 27 2012	Jul. 26 2013		

Elect	Electrostatic discharge							
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)		
1	ESD Simulator	EMPEK	ESD-2030A	GTS242	Jul. 07 2012	Jul. 06 2013		
2	Thermo meter	KTJ	TA328	GTS243	Jul. 06 2012	Jul. 05 2013		



Flicker							
ltem	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)	
1	Power Analyzer	EMTEST	DPA500	GTS235	Jul. 03 2012	Jul. 02 2013	
2	AC Power Source	EMTEST	ACS500	GTS236	Jul. 03 2012	Jul. 02 2013	
3	Test software	EMTEST	ACS	N/A	N/A	N/A	
4	Thermo meter	KTJ	TA328	GTS256	Jul. 05 2012	Jul. 04 2013	

Radi	Radio-frequency electromagnetic field Amplitude modulated						
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)	
1	3m Semi-Anechoic Chamber	ETS-LINDGREN	N/A	SEL0017	June 15 2012	June 16 2013	
2	Signal Generator	Rohde & Schwarz	SML03	SEL0068	June 22 2012	June 23 2013	
3	RF Amplifier 30M-1GHz	Amplifier Research	250W1000A	SEL0066	Nov. 04 2012	Nov. 03 2013	
4	RF Amplifier 0.8-3.0GHz	Amplifier Research	60S1G3	SEL0065	Nov. 04 2012	Nov. 03 2013	
5	Power Meter	Rohde & Schwarz	NRVD	SEL0069	June 22 2012	June 23 2013	
6	Power Sensor	Rohde & Schwarz	URV5-Z2	SEL0071	June 22 2012	June 23 2013	
7	Power Sensor	Rohde & Schwarz	URV5-Z2	SEL0072	June 22 2012	June 23 2013	
8	Software EMC32	Rohde & Schwarz	EMC32-S	SEL0082	N/A	N/A	
9	Log-periodic Antenna	Amplifier Research	AT1080	SEL0073	N/A	N/A	
10	Antenna Tripod	Amplifier Research	TP1000A	SEL0074	N/A	N/A	
11	High Gain Horn Antenna (0.8-5GHz)	Amplifier Research	AT4002A	SEL0075	N/A	N/A	

Radio	Radio-frequency continuous conducted							
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)		
1	RF-Generator	SCHAFFNER	NSG 2070	SEL0039	Oct. 21 2012	Oct. 20 2013		
2	Coupling/Decoupling Network	SCHAFFNER	CDN M016	SEL0040	Oct. 21 2012	Oct. 20 2013		
3	EM CLAMP	SCHAFFNER	KEMZ 801	SEL0041	Oct. 21 2012	Oct. 20 2013		

Gene	General used equipment:						
ltem	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (dd-mm-yy)	Cal.Due date (dd-mm-yy)	
1	Barometer	ChangChun	DYM3	GTS257	July 10 2012	July 09 2013	



7 Emission Test Results

7.1 Radiated Emission

Test Requirement:	EN 55022					
Test Method:	EN 55022					
Test Frequency Range:	30MHz to 5GHz					
Class / Severity:	Class B					
Test site:	Measurement Di	stance: 3m				
Receiver setup:	1					
	Frequency	Detecto		RBW	VBV	
	30MHz-1GHz	Quasi-pe	ак	120KHz	300K	· · ·
	Above 1GHz	Peak Peak		1MHz 1MHz	3M⊢ 3M⊢	
Limit:		Feak			JIVII	12 Average
	Frequen	CV	Lim	nit (dBµV/m	@3m)	Value
	30MHz-230			40.00	<u> </u>	Quasi-peak
	230MHz-1	GHz		47.00		Quasi-peak
	1GHz-30			70.00		Peak
	1GHz-30			50.00		Average
	3GHz-60 3GHz-60			74.00 54.00		Peak Average
Test setup:	Below 1GHz:			54.00		Average
	Arterna Tower Anterna Tower Anterna Tower (Turntable) Ground Reference Plane Test Receiver					
	AE EUT Ground Reference Plane Test Receiver Anterina Controller			Smmmm		



Test Procedure:	From 30MHz to 1GHz:
	1. The radiated emissions test was conducted in a semi-anechoic
	chamber.
	 The tabletop EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane, but separated from metallic contact with the ground reference plane by 0.1m of insulation.
	Before final measurements of radiated emissions, a pre-scan was performed in the spectrum mode with the peak detector to find out the maximum emissions spectrum plots of the EUT.
	4. The frequencies of maximum emission were determined in the final radiated emissions measurement. At each frequency, the EUT was rotated 360°, and the antenna was raised and lowered from 1 to 4 meters in order to determine the maximum disturbance. Measurements were performed for both horizontal and vertical antenna polarization.
	Above 1GHz:
	1. The radiated emissions test was conducted in a fully-anechoic chamber.
	2. The tabletop EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane, but separated from metallic contact with the ground reference plane by 0.1m of insulation.
	Before final measurements of radiated emissions, a pre-scan was performed in the spectrum mode with the peak detector to find out the maximum emission spectrum plots of the EUT.
	4. The frequencies of maximum emission were determined in the final radiated emissions measurement. At each frequency, the EUT was rotated 360°, and the antenna was raised and lowered from 1 to 4 meters in order to determine the maximum disturbance. Measurements were performed for both horizontal and vertical antenna polarization.
Test environment:	Temp.: 25 °C Humid.: 52% Press.: 1 012mbar
Measurement Record:	Uncertainty: ± 4.50dB
Test Instruments:	Refer to section 6 for details
Test mode:	Refer to section 5.3 for details
Test results:	Pass

Measurement Data



Below 1GHz:

6

744.866

46.98

22.39

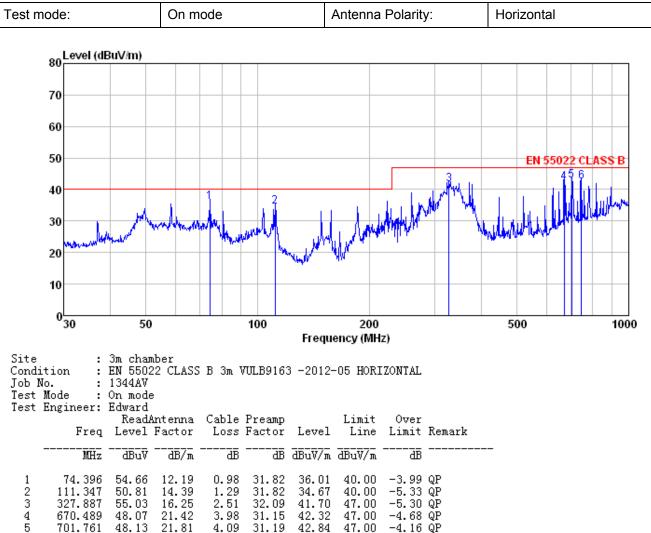
4.26

31.25

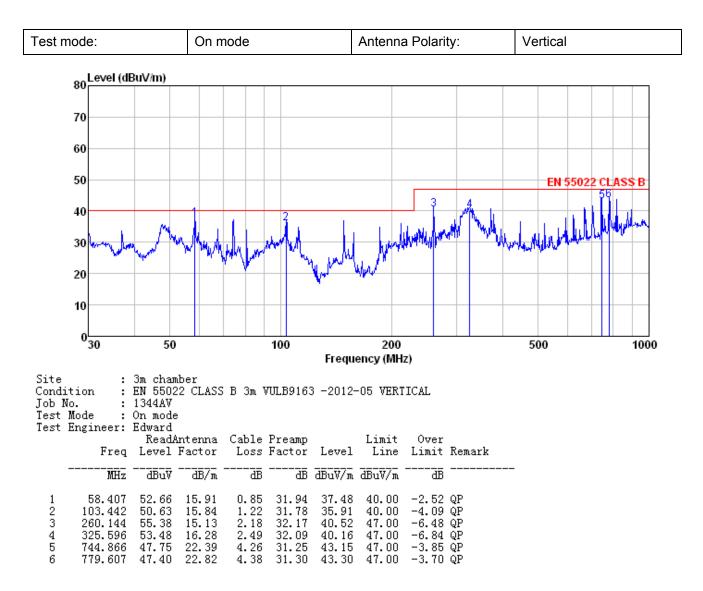
42.38

47.00

-4.62 QP

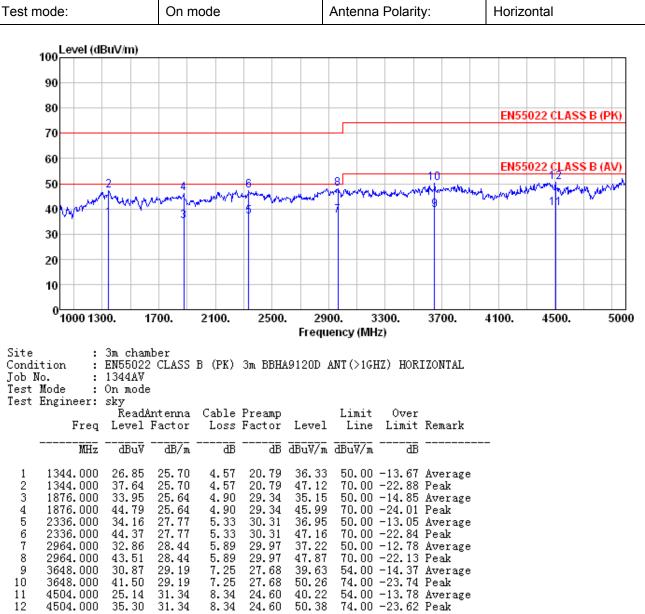




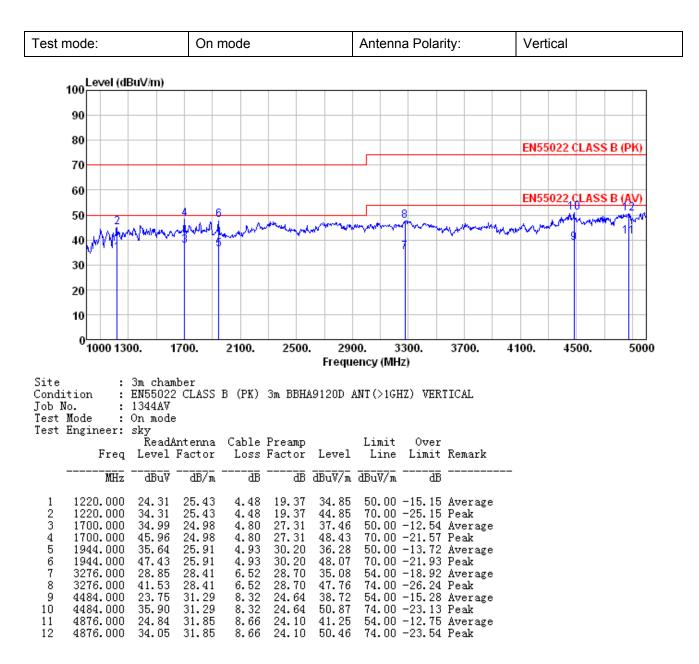




Above 1GHz:







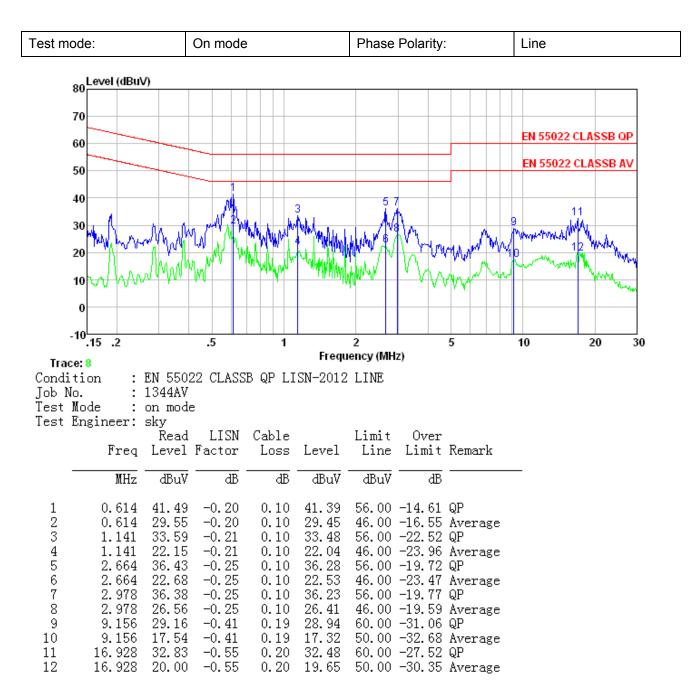


7.2 Conducted Emission

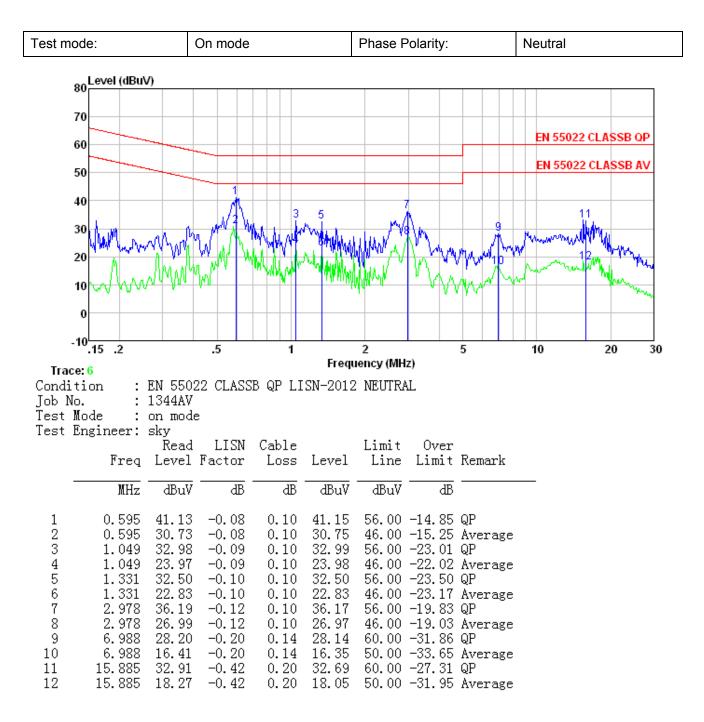
Test Requirement:	EN 55022		
Test Method:	EN 55022		
Test Frequency Range:	150kHz to 30MHz		
Class / Severity:	Class B		
Receiver setup:	RBW=9kHz, VBW=30kHz		
Limit:			
	Frequency range (MHz)	Limit (c	
		Quasi-peak	Average
	0.15-0.5	66 to 56* 56	56 to 46* 46
	5-30	60	50
	* Decreases with the logarithm		
Test setup:	Reference	Plane	
Tost procedure	LISN 40cm AUX E.U.T Equipment E.U.T Test table/Insulation plane Remark: E.U.T. Equipment Under Test LISN: Line Impedence Stabilization Net Test table height=0.8m	EMI Receiver	— AC power
Test procedure	 The E.U.T and simulators are connected to the main power through a line impedance stabilization network(L.I.S.N.). The provide a 50ohm/50uH coupling impedance for the measuring equipment. The peripheral devices are also connected to the main power through a LISN that provides a 50ohm/50uH coupling impedance with 50ohm termination. (Please refers to the block diagram of the test setup and photographs). Both sides of A.C. line are checked for maximum conducted interference. In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed 		
Test environment:	according to EN55022 Clas Temp.: 24 °C Humid.:		-
Measurement Record:		: :	certainty: ±3.45dB
 Test Instruments:	Refer to section 6 for details		
 Test mode:	Refer to section 5.3 for details		
Test results:	Pass		

Measurement Data











7.3 Harmonics Test Results

Test Requirement:	EN 61000-3-2
Test Method:	N/A: See Remark Below
Remark	There is no need for Harmonics test to be performed on this product (rated power is less than 75W) in accordance with EN 61000-3-2.
	For further details, please refer to Clause 7, Note 1 of EN 61000-3-2 which states:
	"For the following categories of equipment limits are not specified in this edition of the standard.
	Note 1: Equipment with a rated power of 75W or less, other than lighting equipment."

7.4 Flicker Emission

Test Requirement:	EN 61000-3-3		
Test Method:	EN 61000-3-3		
Class/Severity:	Clause 5 of EN 61000-3-3		
Measurement Time:	10 min		
Detector:	As per EN 61000-3-3		
Test environment:	Temp.: 24 °C Humid.: 51% Press.: 1 012mbar		
Test Instruments:	Refer to section 6 for details		
Test mode:	Refer to section 5.3 for details		
Test results:	Pass		

Measurement Data

Test Item	Test Item EUT values		Result
Pst	0.028	1.00	PASS
dc [%]	0.006	3.30	PASS
dmax [%]	0.053	4.00	PASS
dt [s]	0.000	0.50	PASS



8 Immunity Test Results

8.1 Performance Criteria Description in Clause 7 of EN 55024

Criterion A:	The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
	After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.
Criterion B:	During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.
	If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion C:	Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.
	Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.



8.2 Electrostatic discharge

Test Requirement:EN 55024Test Method:EN 61000-4-2Discharge Voltage:Contact Discharge: ±2kV, ±4kV Air Discharge: ±2kV, ±4kV HCP/VCP: ±2kV, ±4kVPolarity:Positive & NegativeNumber of Discharge:Contact Discharge: Minimum 25 times at each test point, Air Discharge: Minimum 10 times at each test point.Discharge Mode:Single DischargeDischarge Period:1 second minimumPerformance Criterion:Criterion BTest setup:Image: Minimum 10 times at each test point.	
Discharge Voltage: Contact Discharge: ±2kV, ±4kV Air Discharge: ±2kV, ±4kV, ±8kV HCP/VCP: ±2kV, ±4kV Polarity: Positive & Negative Number of Discharge: Contact Discharge: Minimum 25 times at each test point, Air Discharge: Minimum 10 times at each test point. Discharge Mode: Single Discharge Discharge Period: 1 second minimum Performance Criterion: Criterion B Test setup: Image: Minimum	
Air Discharge: ±2kV, ±4kV, ±8kV HCP/VCP: ±2kV, ±4kV Polarity: Positive & Negative Number of Discharge: Contact Discharge: Minimum 25 times at each test point, Air Discharge: Minimum 10 times at each test point. Discharge Mode: Single Discharge Discharge Period: 1 second minimum Performance Criterion: Criterion B Test setup: Image: Minimum	
HCP/VCP: ±2kV, ±4kV Polarity: Positive & Negative Number of Discharge: Contact Discharge: Minimum 25 times at each test point, Air Discharge: Minimum 10 times at each test point. Discharge Mode: Single Discharge Discharge Period: 1 second minimum Performance Criterion: Criterion B Test setup: Image: Minimum 10 times at each test point.	
Polarity: Positive & Negative Number of Discharge: Contact Discharge: Minimum 25 times at each test point, Air Discharge: Minimum 10 times at each test point. Discharge Mode: Single Discharge Discharge Period: 1 second minimum Performance Criterion: Criterion B Test setup: Image: Criterion B	
Number of Discharge: Contact Discharge: Minimum 25 times at each test point, Air Discharge: Minimum 10 times at each test point. Discharge Mode: Single Discharge Discharge Period: 1 second minimum Performance Criterion: Criterion B Test setup: Image: Minimum and the setup:	
Air Discharge: Minimum 10 times at each test point. Discharge Mode: Single Discharge Discharge Period: 1 second minimum Performance Criterion: Criterion B Test setup: Image: Criterion B	
Discharge Mode: Single Discharge Discharge Period: 1 second minimum Performance Criterion: Criterion B Test setup: Image: Criterion B	
Discharge Period: 1 second minimum Performance Criterion: Criterion B Test setup: Image: Criterion B	
Performance Criterion: Criterion B Test setup: Image: Criterion B	
Test setup:	
Electrostatic Discharge EUT 470K ohm HCP(13m70 an) 470K ohm Non-Conducted Table 70K ohm Ground Reference Plane	
Test Procedure: 1. Air discharge:	
The test was applied on non-conductive surfaces of EUT. The roun discharge tip of the discharge electrode was approached as fast as possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a n single discharge and repeated 10 times for each pre-selected test p. This procedure was repeated until all the air discharge completed	ctrode ew
2. Contact Discharge:	
The test was applied on conductive surfaces of EUT. the generator re-triggered for a new single discharge and repeated 25 times for e pre-selected test point. the tip of the discharge electrode was touch EUT before the discharge switch was operated.	ach
3. Indirect discharge for horizontal coupling plane	
At least 10 single discharges shall be applied at the front edge of each HCP opposite the centre point of each unit of the EUT and 0.1m from front of the EUT. The long axis of the discharge electrode shall be in plane of the HCP and perpendicular to its front edge during the discharge.	m the
Consideration should be given to exposing all sides of the EUT.	
4. Indirect discharge for vertical coupling plane	

	At least 10 single discharges were applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, was placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges were applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.			
Test environment:	Temp.:24 °CHumid.:51%Press.:1 012mbar			
Test mode:	Refer to section 6 for details			
Test Instruments:	Refer to section 5.3 for details			
Test results:	Pass			

Measurement Record:

Test points:	I: Metal interface, Screws, video out port II: All plastic seams, audio in port, audio out port, Camera Lense					
rest points.						
Direct discharge						
Discharge Voltage (KV)	Type of discharge	Test points	Observations (Performance Criterion)	Result		
\pm 2, \pm 4	Contact	I	A	Pass		
± 2, ± 4,± 8 Air		II	A	Pass		
Indirect discharge						
Discharge Voltage (KV)	Type of discharge	Test points	Observation Performance	Result		
$\pm 2, \pm 4$	HCP-Bottom/Top/ Front/Back/Left/Right	Edge of the HCP	A	Pass		
± 2, ± 4	VCP-Front/Back	Center of the VCP	А	Pass		

Remark:

A: No degradation in performance of the EUT was observed.



8.3 Radio-frequency elect	tromagnetic field Amplitude modulated		
Test Requirement:	EN 55024		
Test Method:	EN 61000-4-3		
Frequency range:	80MHz to 1GHz		
Test Level:	3V/m		
Modulation:	80%, 1kHz Amplitude Modulation		
Performance Criterion:	Criterion A		
Test setup:	Camera Camera Antenna Tower AE EUT (Turntable) Ground Reference Plane Ground Reference Plane Signal Generator Power Amplifier		
Test Procedure:	 For table-top equipment, the EUT was placed in the chamber on a non-conductive table 0.8m high. For arrangement of floor-standing equipment, the EUT was mounted on a non-conductive support 0.1m above the supporting plane. For human body-mounted equipment, the EUT may be tested in the same manner as table top items. If possible, a minimum of 1 m of cable is exposed to the electromagnetic field. Excess length of cables interconnecting units of the EUT shall be bundled low-inductively in the approximate center of the cable to form a bundle 30 cm to 40 cm in length. The EUT was initially placed with one face coincident with the calibration plane. The EUT face being illuminated was contained within the UFA (Uniform Field Area). The frequency ranges to be considered were swept with the signal modulated and pausing to adjust the RF signal level or to switch oscillators and antennas as necessary.Where the frequency range was swept incrementally, the step size was not exceed 1 % of the preceding frequency value. The dwell time of the amplitude modulated carrier at each frequency was not be less than the time necessary for the EUT to be exercised and to respond, and was not less than 0,5 s. The test normally was performed with the generating antenna facing each side of the EUT. The polarization of the field generated by each antenna necessitates testing each selected side twice, once with the antenna positioned 		

8.3 Radio-frequency electromagnetic field Amplitude modulated

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	 vertically and again with the antenna positioned horizontally. 8. The EUT was performed in a configuration to actual installation conditions, a video camera and/or a audio monitor were used to monitor the performance of the EUT. 			
Test environment:	Temp.: 25 °C Humid.: 52% Press.: 1 012mbar			
Test Instruments:	Refer to section 6 for details			
Test mode:	Refer to section 5.3 for details			
Test results:	Pass			

Measurement Record:

Frequency	Level	Modulation	Antenna Polarization	EUT Face	Observations (Performance Criterion)	Result
			V	- ·	А	Pass
			Н	Front	А	Pass
			V	_	А	Pass
		1 kHz, 80 % Amp. Mod, 1 % increment, dwell time=3seconds	Н	Rear	А	Pass
80 MHz-1 GHz	3 V/m		V		А	Pass
			Н	Left	А	Pass
			V	Right	А	Pass
			Н		А	Pass
			V	Тор	А	Pass
			Н		А	Pass
			V		А	Pass
			Н	Bottom	А	Pass

Remark:

A: No degradation in performance of the EUT was observed.



Test Requirement: EN 55024 EN 61000-4-4 Test Method: Test Level: 1.0kV on AC port Polarity: **Positive & Negative** Test signal specification: Rise time=5ns, Duration time=50ns; Burst Duration=15ms, Burst Period=300ms; Repetition Frequency=5KHz Test Duration: 2 minute per level & polarity Performance Criterion: Criterion B Test setup: EMC Tester EUT 10cm Non-conducted table Ground Reference Plane Grounding cable 80[°]cm Ground Reference Plane Test Procedure: 1. The EUT and its simulators were placed on the ground reference plane and were insulated from it by a wood support 0.1m + 0.01m thick. The ground reference plane was 1m*1m metallic sheet with 0.65mm minimum thickness. 2. This reference ground plane was project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane was more than 0.5m. 3. All cables to the EUT was placed on the wood support, cables not subject to EFT/B was routed as far as possible from the cable under test to minimize the coupling between the cables. 4. The length of the signal and power lines between the coupling device and the EUT is 0.5m 5. The EUT is connected to the power mains through a coupling device that directly couples the EFT/B interference signal. Each of the Line and Neutral conductors is impressed with burst 6. noise for 2 minutes. Test environment: Temp.: 26 °C Humid.: 54% Press.: 1 012mbar **Test Instruments:** Refer to section 6 for details Test mode: Refer to section 5.3 for details Test results: Pass

8.4 Electrical fast transients

Measurement Record:



Lead under Test	Level (±kV)	Coupling Direct/Clamp	Observations (Performance Criterion)	Result
L	± 1.0	Direct	A	Pass
N	± 1.0	Direct	A	Pass
L-N	± 1.0	Direct	А	Pass

Remark:

A: No degradation in performance of the EUT was observed.



8.5 Surges

	ourges			
	Test Requirement:	EN 55024		
	Test Method:	EN 61000-4-5		
	Test Level:	1kV line to line: Differential mode		
	Polarity:	Positive & Negative		
	Generator source impedance:	2Ω (line-line coupling)		
	Test signal specification:	Rise time=1.2us, Duration time=50us;		
		Test Interval: 60s between each surge;		
	No. of surges:	5 positive, 5 negative at 0°, 90°, 180°, 270°.		
	Performance Criterion:	Criterion B		
	Test setup:	EMC Tester EUT egg Non-conducted table Bupunous Ground Reference Plane		
 (at open-circuit condition) and 8/20us current surge to EU points, and for active line / neutral lines to ground are sam test level is 2kV. 2. At least 5 positive and 5 negative (polarity) tests with a ma 1/min repetition rate are applied during test. 3. Different phase angles are done individually. 4. Record the EUT operating situation during compliance test 		 (at open-circuit condition) and 8/20us current surge to EUT selected points, and for active line / neutral lines to ground are same except test level is 2kV. 2. At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are applied during test. 3. Different phase angles are done individually. 		
	Test environment:	Temp.: 26 °C Humid.: 53% Press.: 1 012mbar		
	Test Instruments:	Refer to section 6 for details		
	Test mode:	Refer to section 5.3 for details		
	Test results:	Pass		
	root roouito.	1 400		

Measurement Record:



Location	Level(kV)	Pulse No	Surge Interval	Phase(deg)	Observations (Performance Criterion)	Result	
		5 60			0°	А	Pass
			60.5	90°	А	Pass	
L-N	± 1		605	180°	A	Pass	
				270°	А	Pass	

Remark:

A: No degradation in performance of the EUT was observed.

Test Requirement:	EN 55024	
Test Method:	EN 61000-4-6	
Frequency range:	0.15MHz to 80MHz	
Test Level:	3V rms on AC Ports (unmodulated emf into 150 Ω)	
Modulation:	80%, 1kHz Amplitude Modulation	
Performance Criterion:	Criterion A	
Test setup:	Shielding Room	
Test Procedure:	 The EUT are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane about 0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible). The disturbance signal described below is injected to EUT through CDN. The EUT aperates within its aperational mode(a) under intended 	
	 The EUT operates within its operational mode(s) under intended climatic conditions after power on. 	
	4. Recording the EUT operating situation during compliance testing and decide the EUT immunity criterion.	
Test environment:	Temp.: 24 °C Humid.: 51% Press.: 1 012mbar	
Test Instruments:	Refer to section 6 for details	
Test mode:	Refer to section 5.3 for details	
Test results:	Pass	

8.6 Radio-frequency continuous conducted

Measurement Record:

Frequency	Injected Position	Level	Modulation	Observations (Performance Criterion)	Result
150kHz to 80MHz	AC Mains	3Vrms	1 kHz, 80 % Amp. Mod, 1 % increment, dwell time=2seconds	A	Pass

Remark:

A: No degradation in performance of the EUT was observed.



• •	<u> </u>				
Test Requirement:	EN 55024				
Test Method:	EN 61000-4-11				
Test Level:	0% of VT(Supply Voltage) for 0.5 period				
	70% of VT(Supply Voltage) for 25 period				
	0% of VT(Supply Voltage) for 250 period				
Number of Dips / Interruptions:	3 per Level				
Performance Criterion:	>95% VD, 0.5 periodPerformance criterion: B				
	30% VD, 25 periodPerformance criterion: C				
	>95% VI, 250 periodPerformance criterion: C				
Test setup:	EMC Tester EUT and a second s				
Test Procedure:	 The EUT and test generator were setup as shown on above setup photo. The interruptions are introduced at selected phase angles with specified duration. Record any degradation of performance. 				
Test environment:	Temp.: 26 °C Humid.: 53% Press.: 1 012mbar				
Test Instruments:	Refer to section 6 for details				
Test mode:	Refer to section 5.3 for details				
Test results:	Pass				

8.7 Voltage dips and Voltage interruptions

Measurement Record:

Test Level % U _T	Duration (Periods)	Phase angle	No. of drop out	Time between dropout	Observations (Performance Criterion)	Result
0	0.5	0°, 90°, 180°, 270°	3	10s	А	Pass
70	25	0°, 90°, 180°, 270°	3	10s	А	Pass
0	250	0°, 90°, 180°, 270°	3	10s	С	Pass

Remark:

A: No degradation in performance of the EUT was observed.

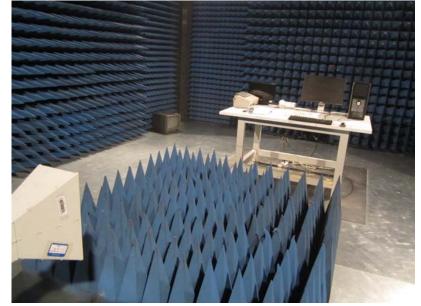
C: During the test, the EUT power off, after the experiment, the function can return to normal by the user.



9 Test Setup Photo

Radiated Emission





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Conducted Emissions



Electrostatic discharge







Electrical fast transients/ Surges/ Voltage dips and interruptions

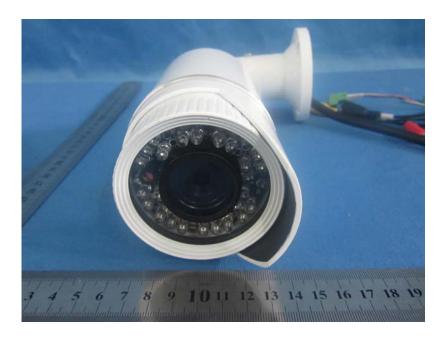


10 EUT Constructional Details











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